

Oscillator (CMOS/LVPECL/LVDS/HCSL Output)

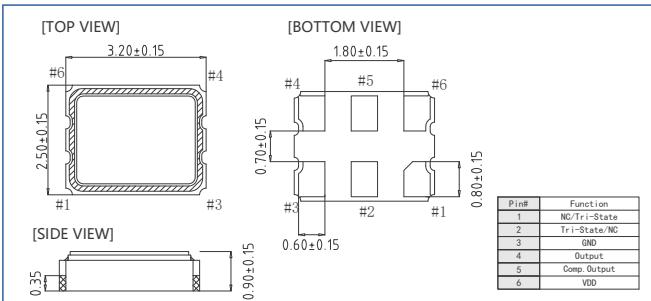
LV3225

3.2 x 2.5 mm SMD LVPECL/LVDS/ HCSL Crystal Oscillator

FEATURES

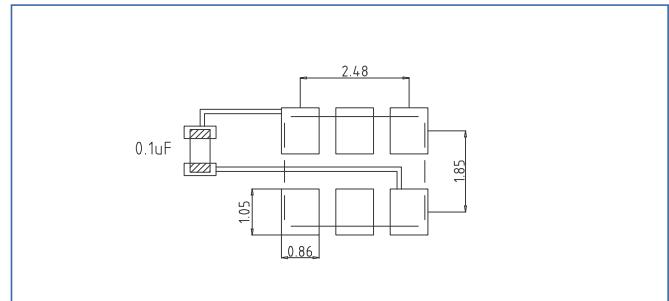
- Industry Standard 3.2 x 2.5 x 0.9 hermetically sealed ceramic package
- Very low jitter performance: typical 0.1 pS RMS from 12 kHz ~ 20 MHz
- Fundamental/3rd overtone crystal design
- Output frequency up to 250 MHz
- Tri-state enable/disable
- Up to 125°C operating temperature range

DIMENSIONS



TYPICAL APPLICATION

- 10 Gbit Ethernet, Fiber Channel, Storage Area Network, SONET
- Enterprise Servers, Reference clocks for ADC and DAC
- Telecom



ELECTRICAL SPECIFICATION

Parameter	LVPECL				LVDS				Unit	
	3.3V		2.5V		3.3V		2.5V			
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
Supply Voltage Variation (VDD)	VDD-5%	VDD+5%	VDD-5%	VDD+5%	VDD-5%	VDD+5%	VDD-5%	VDD+5%	V	
Frequency Range	10	250	10	250	10	250	10	250	MHz	
Standard Frequency	25, 106.25, 125, 156.25, 161.1328, 212.5									
Supply Current	10MHz≤F _o <160MHz	—	75	—	75	—	50	—	mA	
	160MHz≤F _o <250MHz	—	100	—	100	—	50	—		
Output Level	Output High	2.275	—	1.475	—	—	1.6	—	V	
	Output Low	—	1.68	—	0.88	0.9	—	0.9		
Transition Time: Rise/Fall Time+	—	1	—	1	—	1	—	1	nSec	
Startup Time	—	10	—	10	—	10	—	10	mSec	
Tri-State (Input to Pin2 or Pin1)	Enable (High Voltage or Floating)	2.31	—	1.75	—	2.31	—	1.75	V	
	Disable (Low Voltage or GND)	—	0.99	—	0.75	—	0.99	—		
Aging (@25°C, 1st Year)	—	±3	—	±3	—	±3	—	±3	ppm	
Storage Temp. Range	-55	125	-55	125	-55	125	-55	125	°C	
Phase Noise @ 156.25 MHz	100 Hz	-95		-90		-90		-90		
	1 kHz	-125		-125		-120		-120		
	10 kHz	-140		-140		-140		-140		
RMS Phase Jitter (Integrated 12 KHz ~ 20MHz)	F _o <80MHz	—	1	—	1	—	1	—	pSec	
	80MHz≤F _o <125MHz	—	0.5	—	0.5	—	0.5	—		
	125MHz≤F _o <170MHz	—	0.3	—	0.3	—	0.3	—		
	170MHz≤F _o <200MHz	—	0.5	—	0.5	—	0.5	—		
	200MHz≤F _o	—	0.3	—	0.3	—	0.3	—		

Oscillator (CMOS/LVPECL/LVDS/HCSL Output)

Parameter	HCSL				Unit	
	3.3V		2.5V			
	Min.	Max.	Min.	Max.		
Supply Voltage Variation(VDD)	VDD-5%	VDD+5%	VDD-5%	VDD+5%	V	
Frequency Range	25	175	25	175	MHz	
Standard Frequency	100					
Supply Current	25MHz ≤ F_o ≤ 175MHz		—	50	mA	
Output Level	Output High		0.6	—	V	
	Output Low		—	0.15		
Transition Time: Rise/Fall Time+		—	0.5	—	nSec	
Startup Time		—	10	—	mSec	
Tri-State (Input to Pin2 or Pin1)	Enable (High Voltage or Floating)	0.7VDD	—	0.7VDD	V	
	Disable (Low Voltage or GND)	—	0.3VDD	—		
Aging (@25°C, 1st Year)		—	±3	—	ppm	
Storage Temp. Range		-55	125	-55	125	
RMS Phase Jitter (Integrated 12KHz ~ 20MHz)	25MHz ≤ F_o ≤ 175MHz	—	0.5	—	pSec	

Standard frequencies are frequencies which the crystal has been designed and does not imply a stock position.

+ Transition times are measured between 20% and 80% of VDD.

FREQ. STABILITY vs. TEMP. RANGE

Temp.(°C)	ppm	±25	±50
-10 ~ +60	○	○	○
-20 ~ +70	○	○	○
-40 ~ +85	△	○	○
-40 ~ +125	×	○	○

*o: Available Δ: Condition X: Not available

*Inclusive of calibration @ 25 °C, operating temperature range, input voltage variation, load variation, aging (1st year), shock, and vibration.

Note: not all combination of options are available. Other specifications may be available upon request.
Specifications subject to change without notice.